

PATENT APPLICATION

Serial No.:

10/713,673

Group:

2827

INFORMATION DISCLOSURE CITATION FORM PTO-1449 (Modified)

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Exam <u>Init</u>	<u>Ref</u>	Document Number	Issue <u>Date</u>	<u>Name</u>	Class	Sub <u>Class</u>					
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TL	.	Atmel Corporation; 2-Wire Serial EEPROM Revision 0180D; October 1998; Pages 1-21;									
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Examiner:

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PATENT APPLICATION

Atty. Docket No.: 5038-299 Applicant: David Zimmerman Filing Date: November 13, 2003 Serial No.:

10/713,673

Group:

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